

液体Xeカロリメータ用光電子増倍管の 低温における性能評価

Cryogenic performance test of a photomultiplier
for the liquid Xe calorimeter

東京大学素粒子物理国際研究センター
森研究室修士2年
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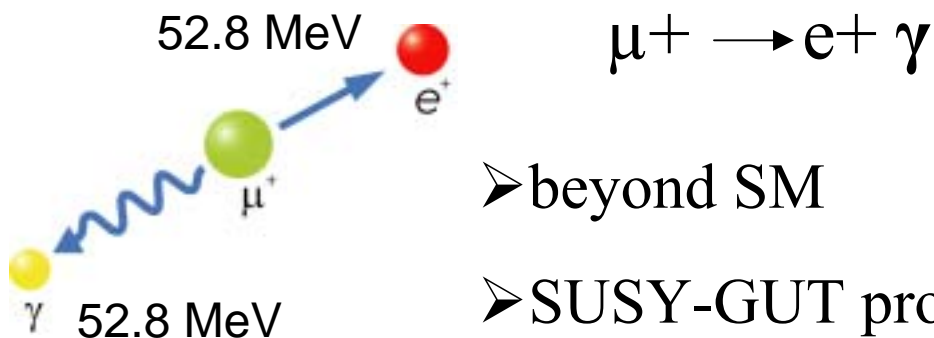
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久松康子 2004年度低温工学・超伝導学会 @八戸工業大学

Abstract

- About MEG Experiment
- PMT for MEG photon detector
- Works on Final Design of PMT
- PMT test at Univ. of Tokyo
- Summary

MEG Experiment



➤ beyond SM

➤ SUSY-GUT promising

MEGA(~1999)

Br $1.2 \cdot 10^{-11}$

MEG

Br 10^{-14}

➤ Approved by Paul Scherrer Institut

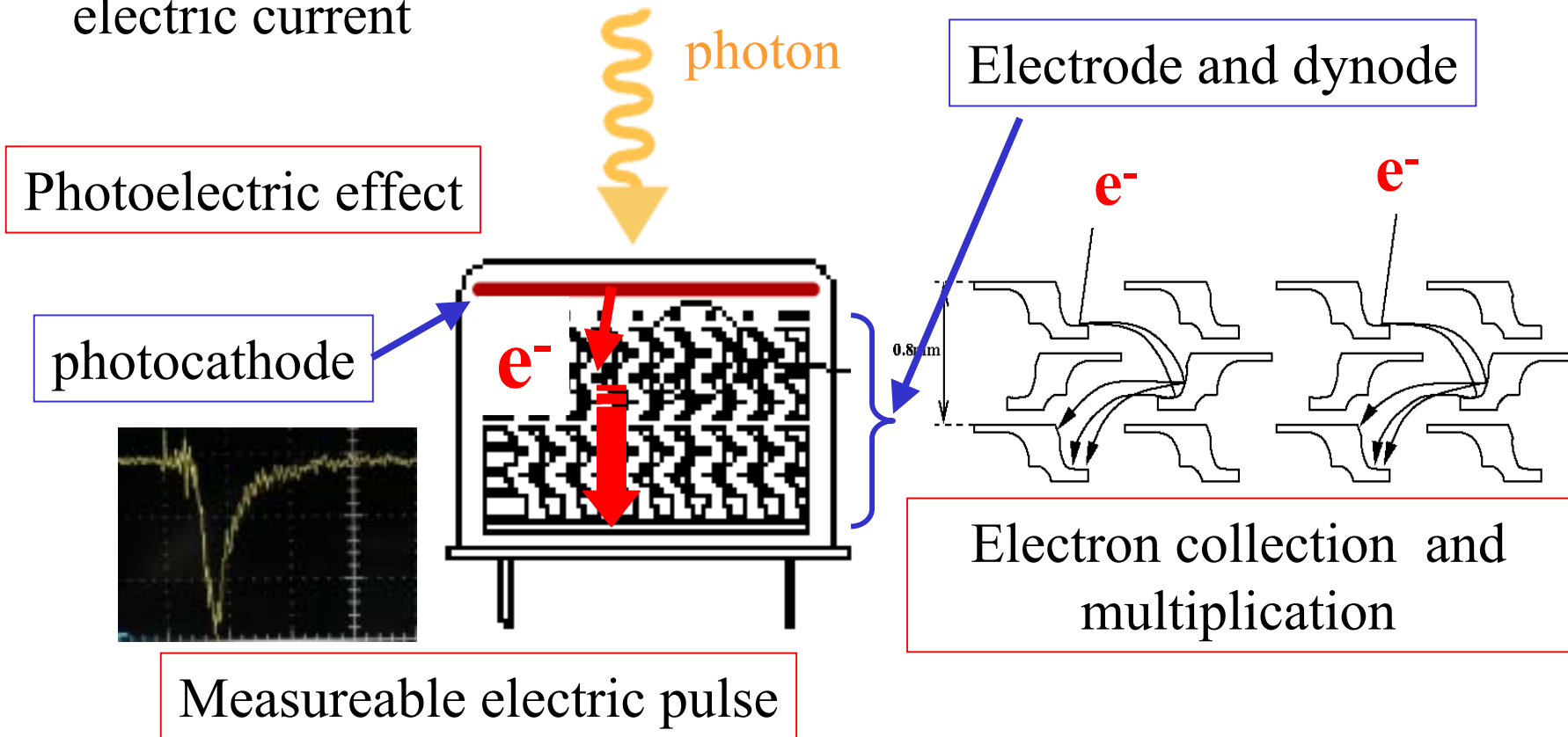
➤ Using intense muon beam @PSI
 $1 \cdot 10^8/\text{sec}$

➤ Start of Physics Run : 2006

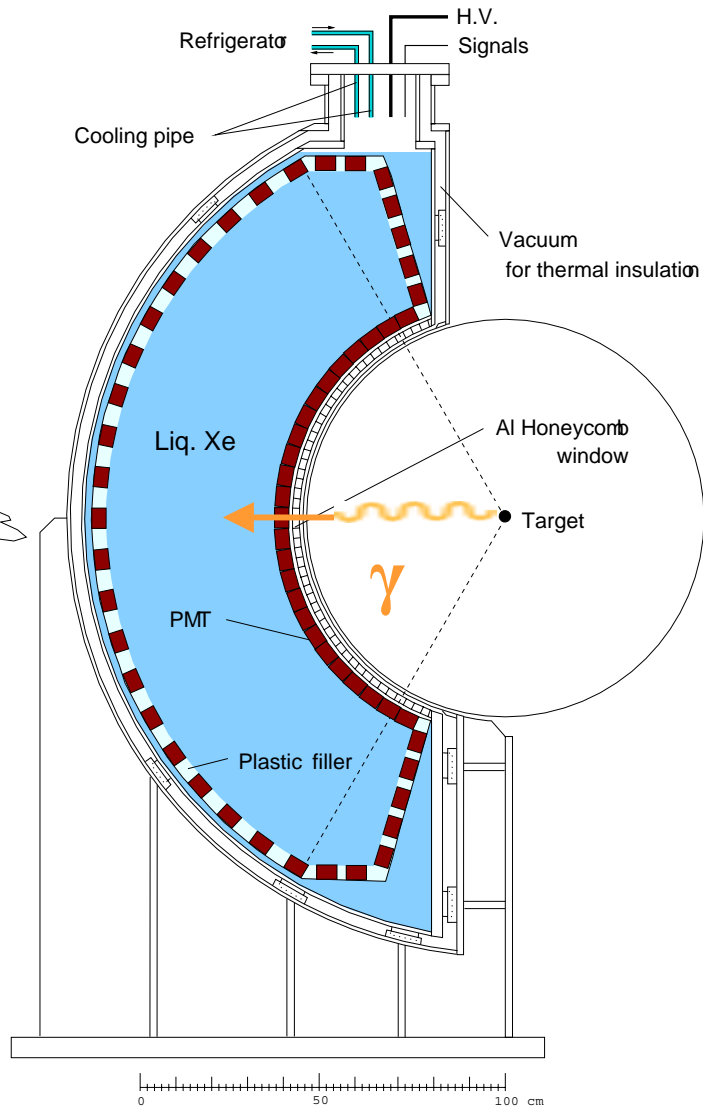


Photomultiplier (PMT)

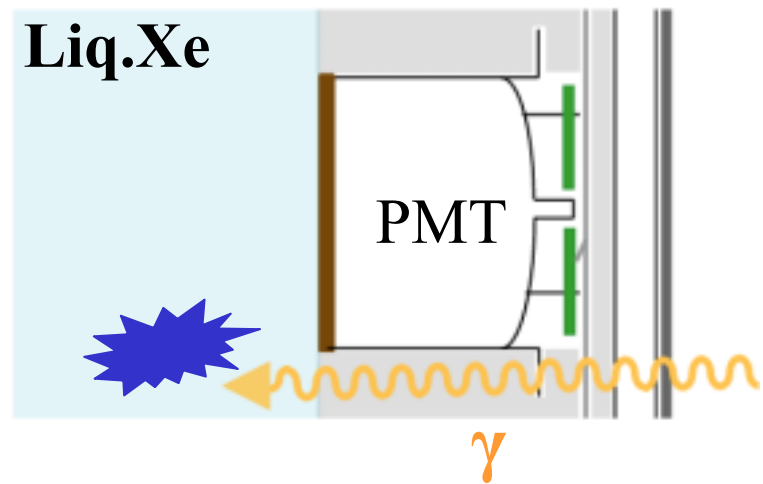
- Highly sensitive light sensor often used in high energy physics experiments
- Electron tube device which converts light into a measurable electric current



MEG Liq. Xe γ detector

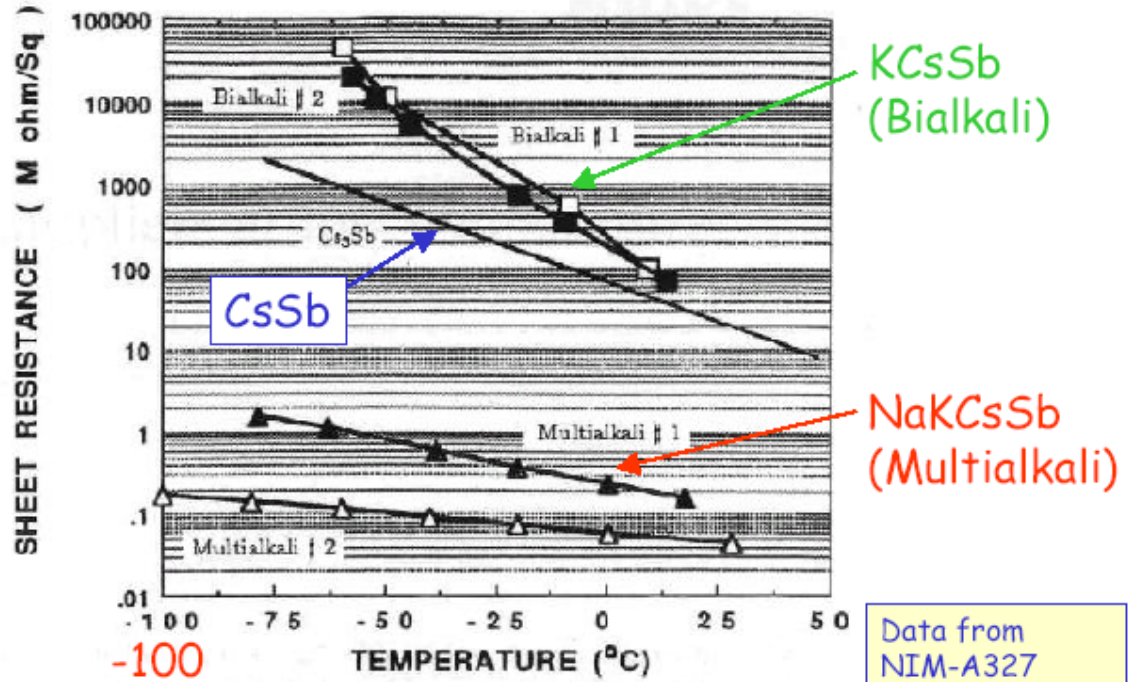
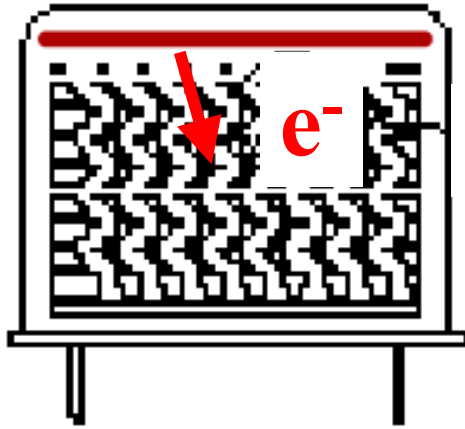


Detect **scintillation light** with 800 Liter liq.Xe and with 830 PMTs



PMT @ 165K (Liq.Xe temp.)

photon
 photocathode

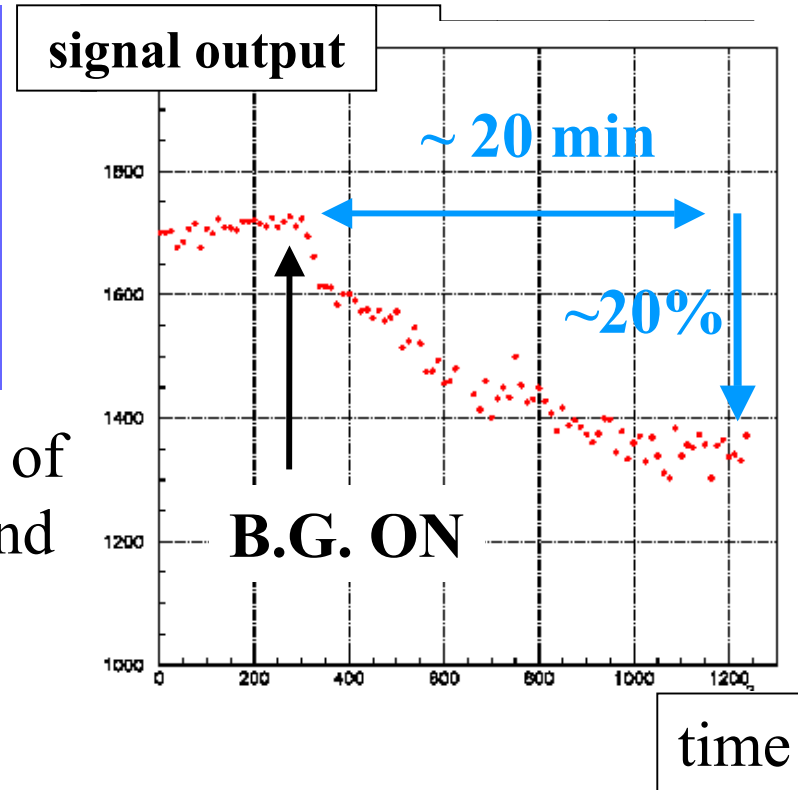
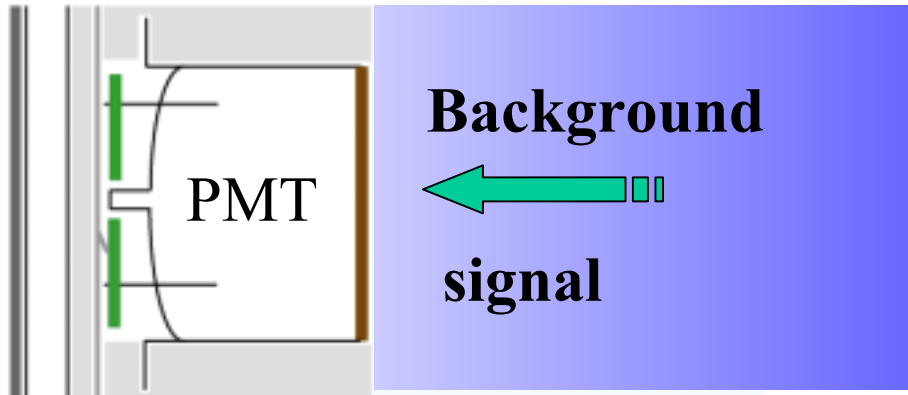


Data from
 NIM-A327
 (1993) 144-147
 Dr.Doke et al.

Temperature ↓
 surface resistance ↑
 Quantum Efficiency ↓
 Signal Output ↓

} Need to reduce surface resistance
 of photocathode

PMT @165K under high rate B.G.



PMT will be exposed to large amount of light produced by high rate background radiation

➔ PMT output needs to be stable under high rate B.G.

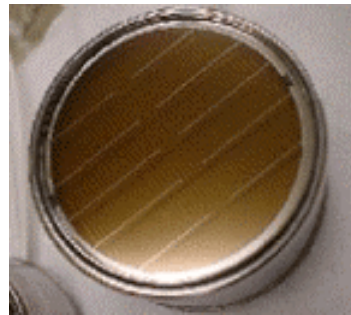
First version PMTs output deteriorates under high rate B.G.
Related to the characteristics of photocathode at the low temperature

Development of PMT for MEG Experiment

- Efficient Q.E. @ 165K (reduction of surface resistance)
- Stable output under high rate background



First Ver.



Second Ver.



Final Ver.

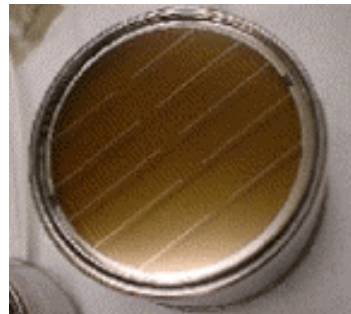
Photocathode	Rb-Cs-Sb	K-Cs-Sb	K-Cs-Sb
Material to reduce surface R	Mn layer	Al Strip	Al Strip (doubled)
Q.E. @ 165K	~5%	?	??

Development of PMT for MEG Experiment

- Efficient Q.E. @ 165K (reduction of surface resistance)
- Stable output under high rate background



First Ver.



Second Ver.



Final Ver.

Photocathode	Rb-Cs-Sb	K-Cs-Sb	K-Cs-Sb
Material to reduce surface R	Mn layer	How much has Q.E. improved? Will PMT survive the high rate background environment @165K ?	
Q.E. @ 165K	~5%		

PMT Test @ Univ. of Tokyo *Liq.Xe chamber*

Pulse tube refrigerator

AISIN PR121

Compressor : TAC 101J

Cooling Power : $\sim 25\text{W}$ @165K

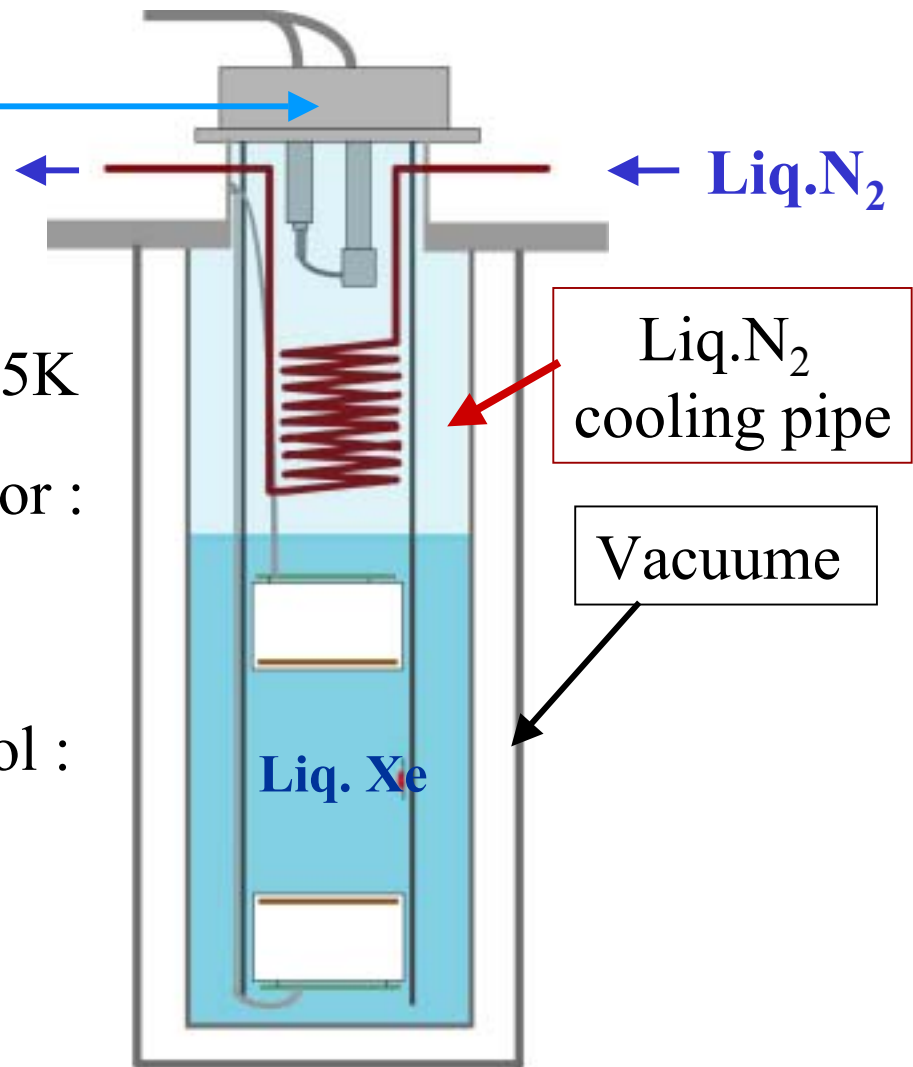
Cold head temperature monitor :

Pt100

Platinum Thin Film Resistance

Cold head temperature control :

MINCO Thermofoil Heater



PMT Test @ Univ. of Tokyo *Liq.Xe chamber*

Pulse tube refrigerator

AISIN PR121

Compressor : TAC 101J

Cooling Power : ~25W @165K

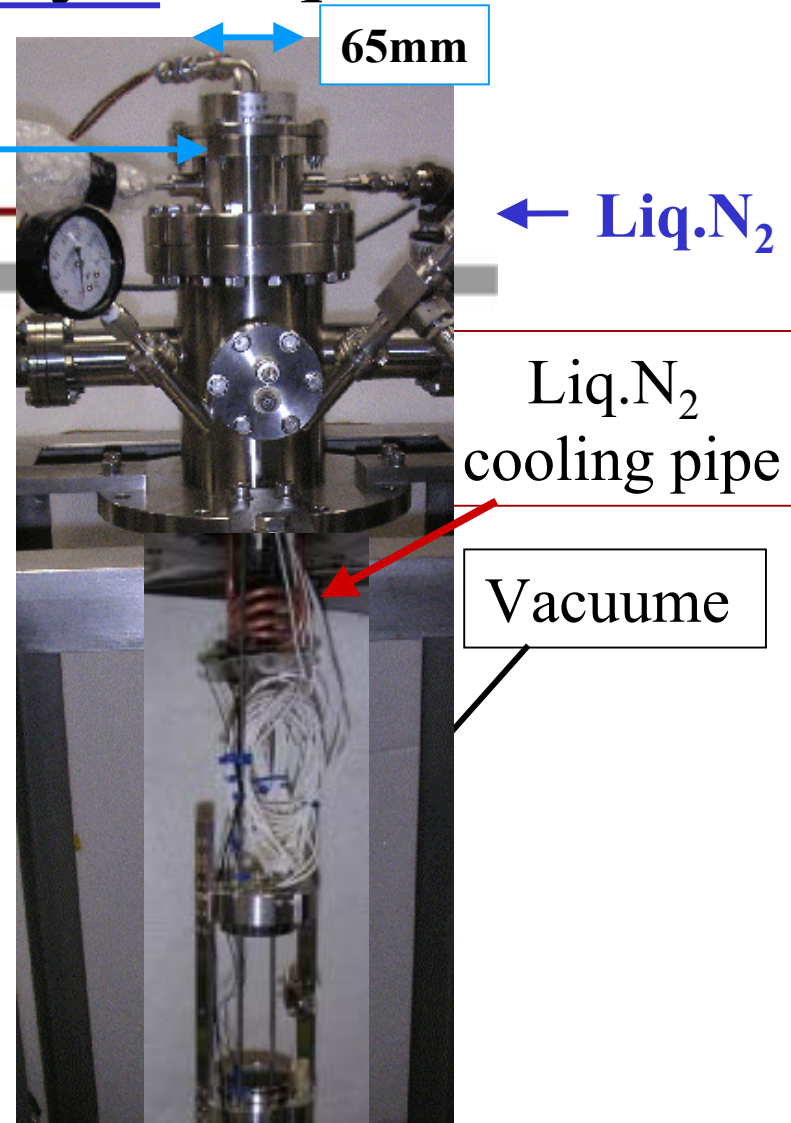
Cold head temperature monitor :

Pt100

Platinum Thin Film Resistance

Cold head temperature control :

MINCO Thermofoil Heater



PMT Test Set up

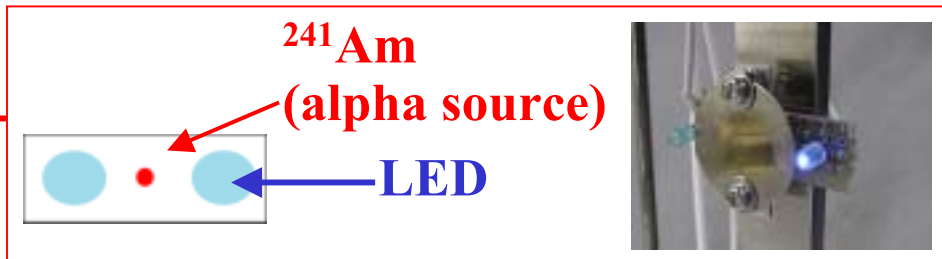
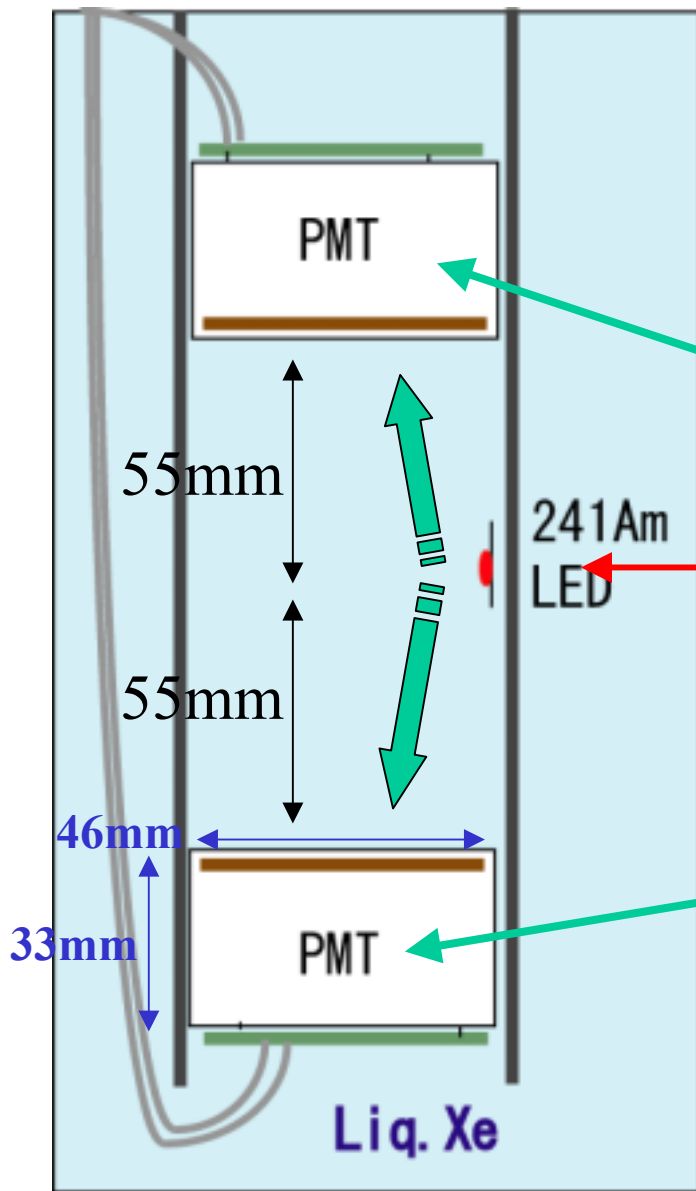
Q.E. measurement

➤ How much has Q.E. improved?

Observe 5.5MeV alpha event
Gain calibration using LED

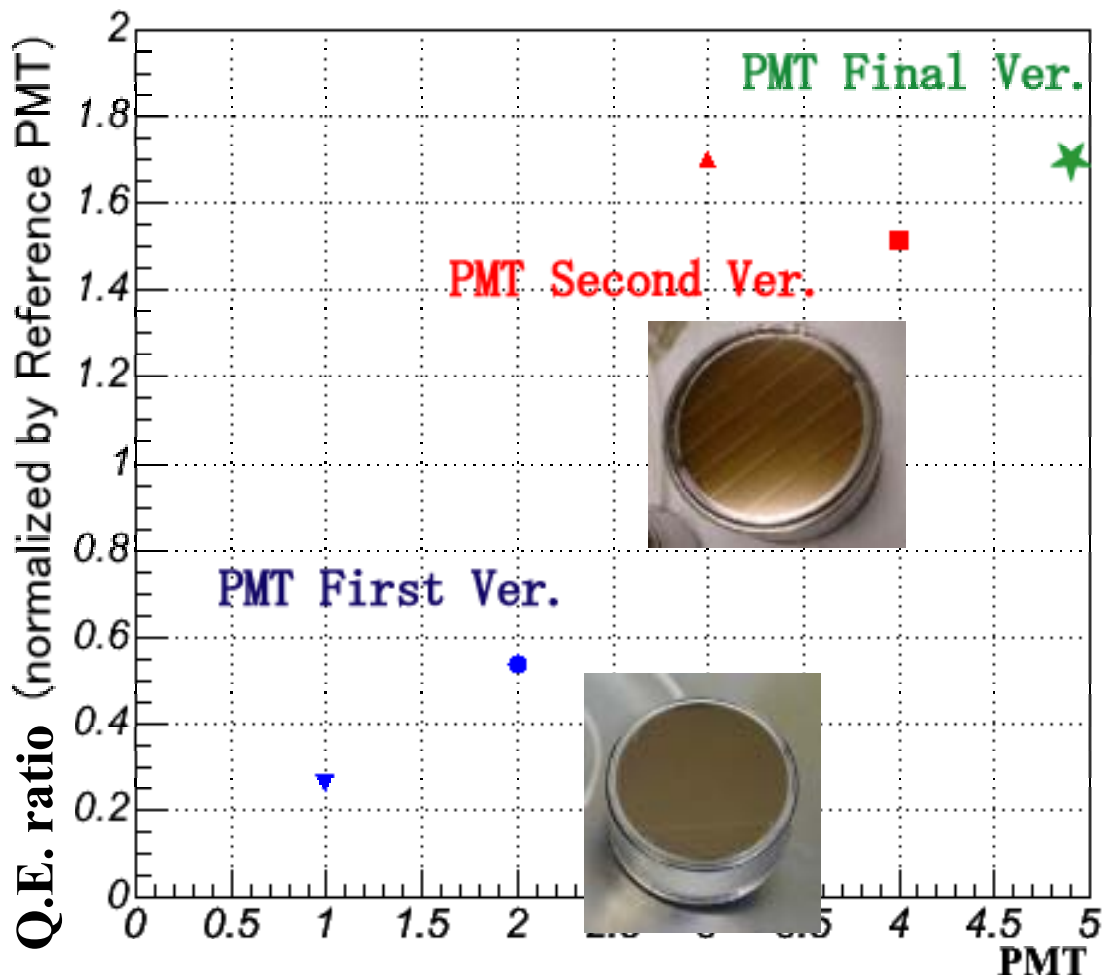
Reference PMT

Gain : 10^6

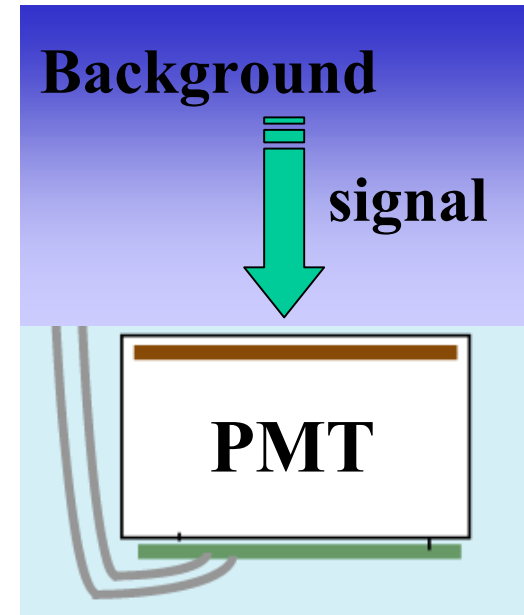
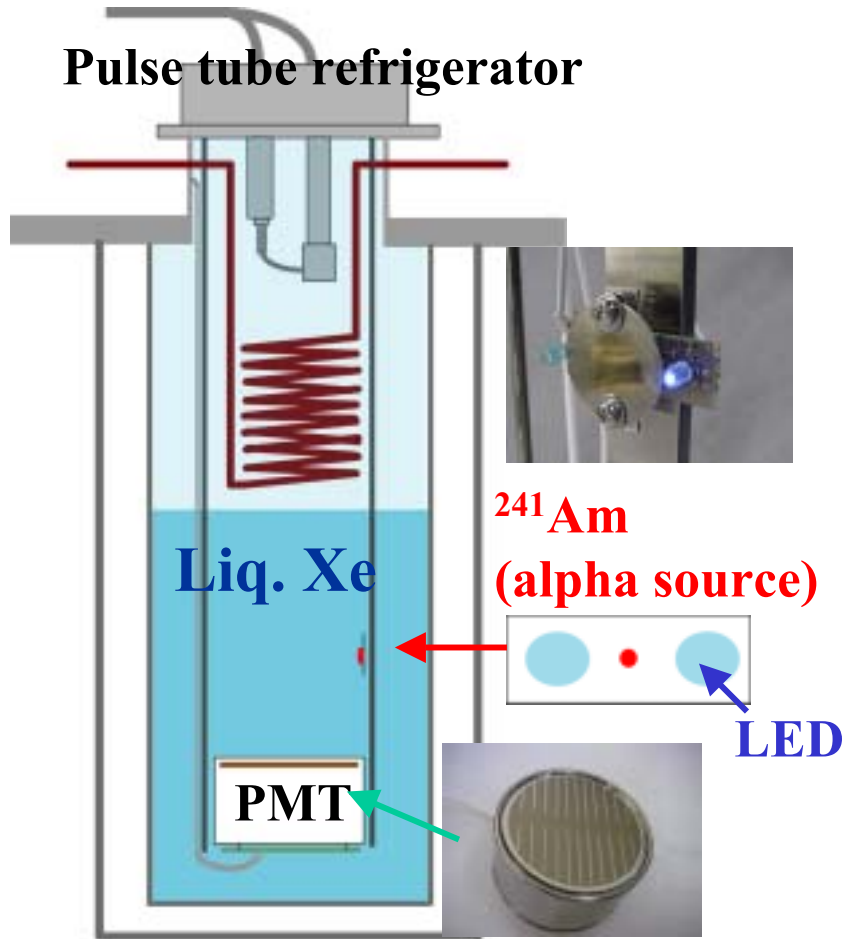


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Q.E. measurement

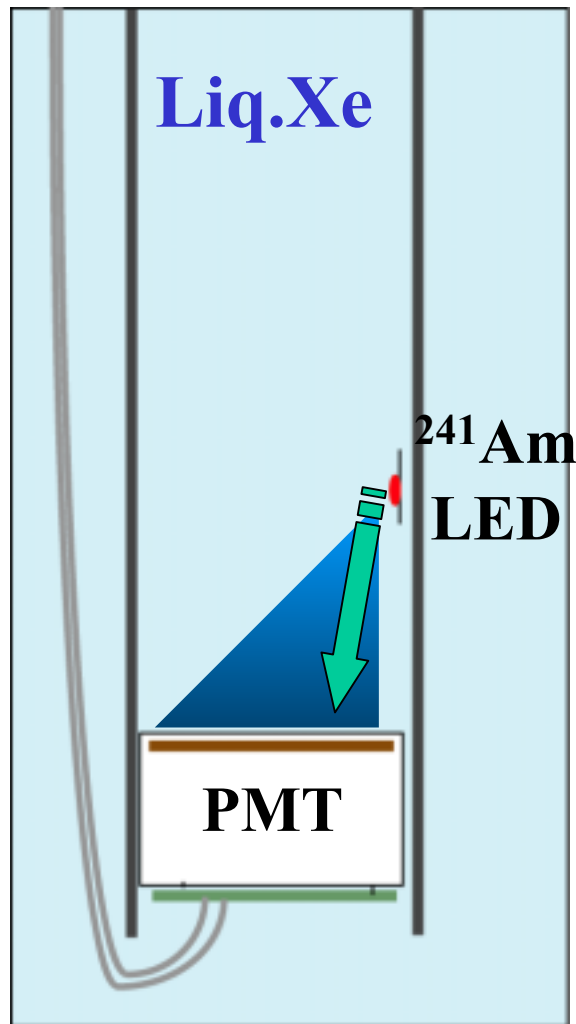


➤ Will PMT survive the high B.G. environment at 165K?



How to simulate High rate B.G. ?
➡ LED

Rate Dependence Test Procedure



LED

- simulate the high rate background
- pulse height: 4000~7200 p.e./event
- pulse shape: ~10nsec
- rate: 500Hz ~ 10KHz



²⁴¹Am
(alpha source)

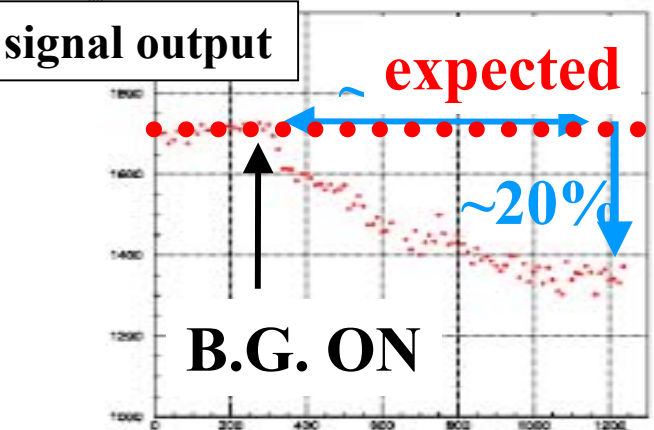


alpha

Observe 5.5MeV alpha event,
~200Hz

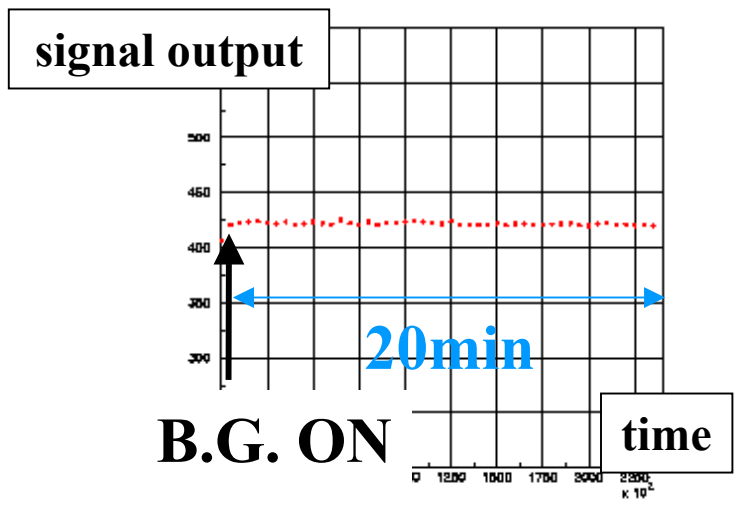


PMT for MEG final version *Rate Dependence @ Liq. Xe*



PMT was tested under various background environment by changing the rate of LED

c.f. First Version PMT



The output from final version PMT is stable under the high rate background environment

Max. B.G. Level in MEG experiment
 1.3×10^7 p.e./sec

Summary

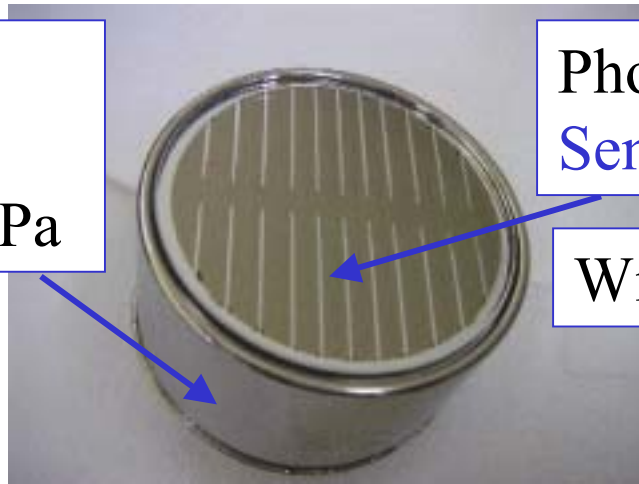
- PMT for MEG experiment has been developed.
 - Able to operate under 165K, Liq.Xe temp.
- Cryogenic performance of Final Version PMT is tested @ liq.Xe.
- PMT has efficient Q.E. even at 165K
- PMT output at 165K is stable under the high rate background environment.

以下予備トラペ

PMT for MEG Experiment

Metal Cover SUS

Able to withstand
pressure up to 0.3MPa



Photocathode : Bialkali
Sensitive to VUV

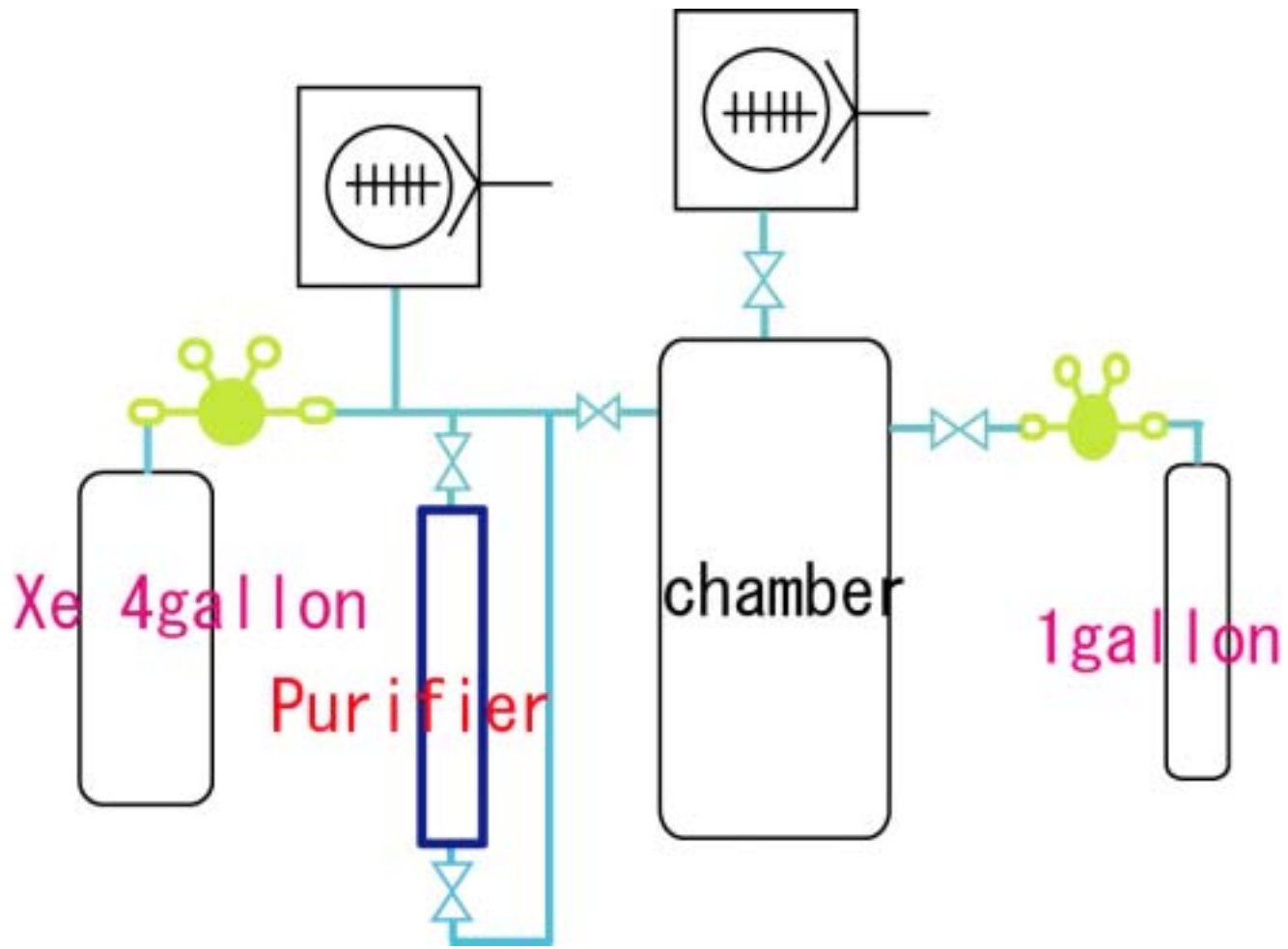
Window : Quartz glass

Kovar Metal

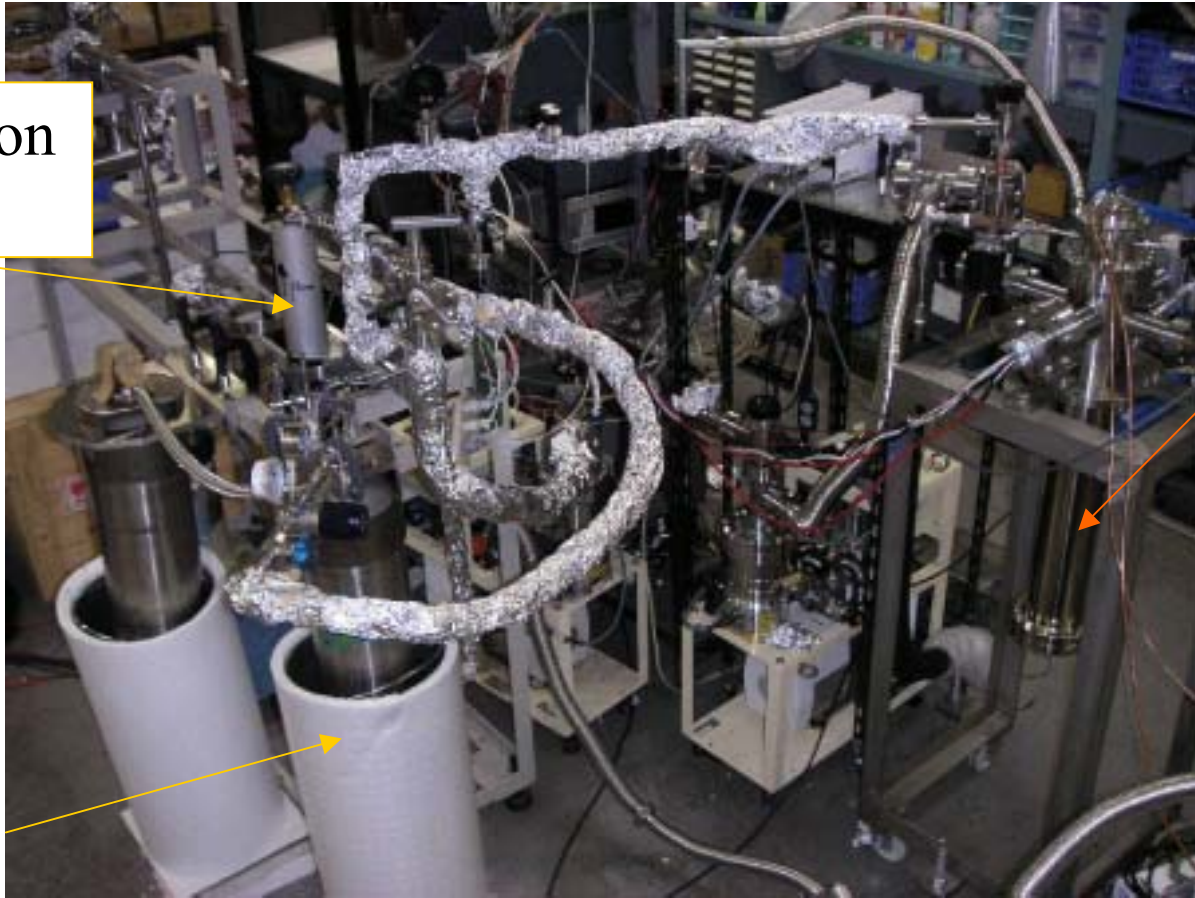


Kovar Glass

Flow sheet @ PMT Test Facility



PMT Test facility @ Univ. of Tokyo



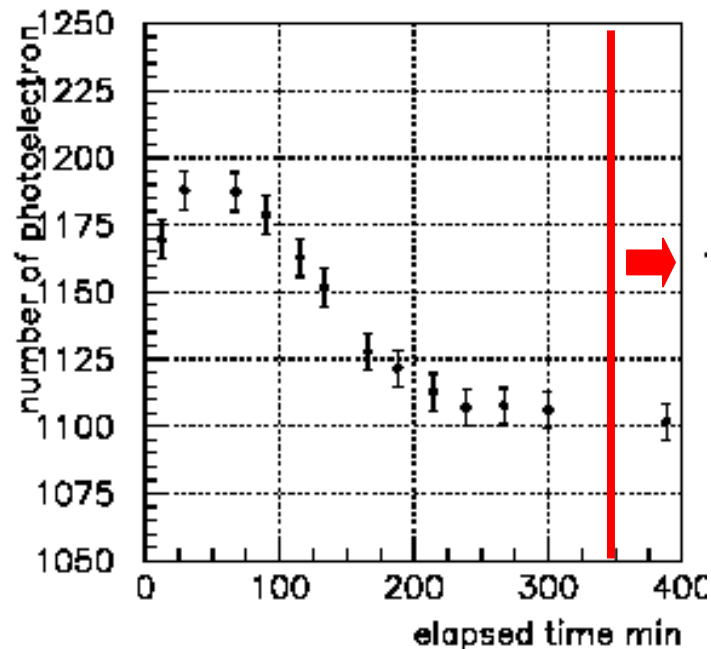
Purification system

Liq.Xe chamber

Xe tank

PMT stability, DAQ Procedure

DAQ started after all chamber components become low temperature



Trigger : alpha self trigger

DAQ Procedure :

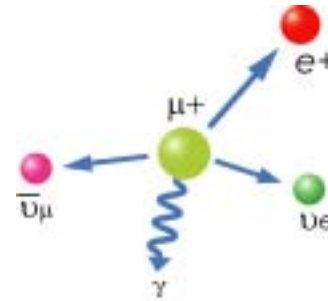
—————▶ Pedestal Run

—————▶ Gain Calibration

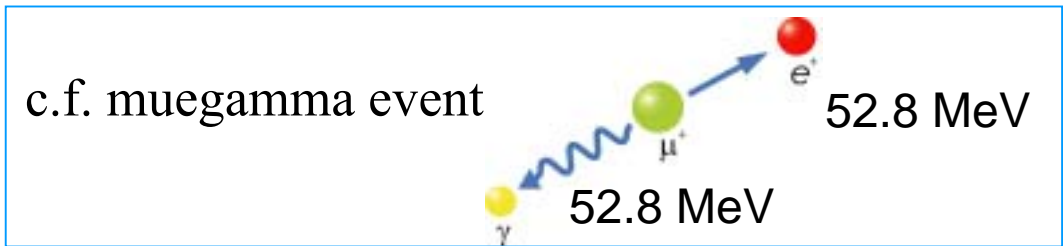
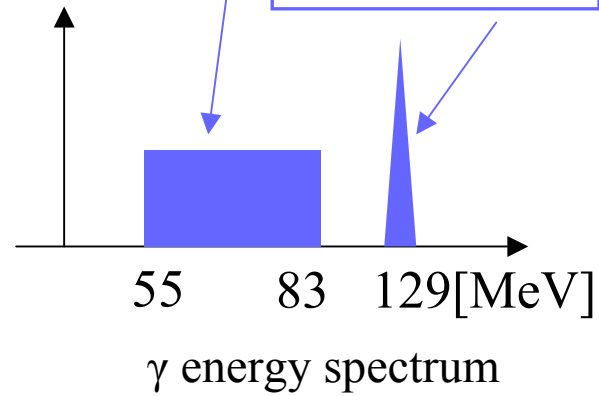
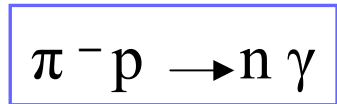
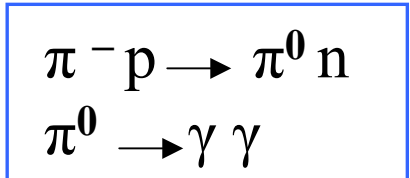
—————▶ alpha run

Major Background for PMT

- muon radiative decay
- Gamma from positron annihilation
- Neutrons from proton beam



- neutrons from pion's CEX reaction (@calibration run)



➡ BG level ~ 2μA @10⁶gain (~10⁷p.e./sec)

Condition and Procedure

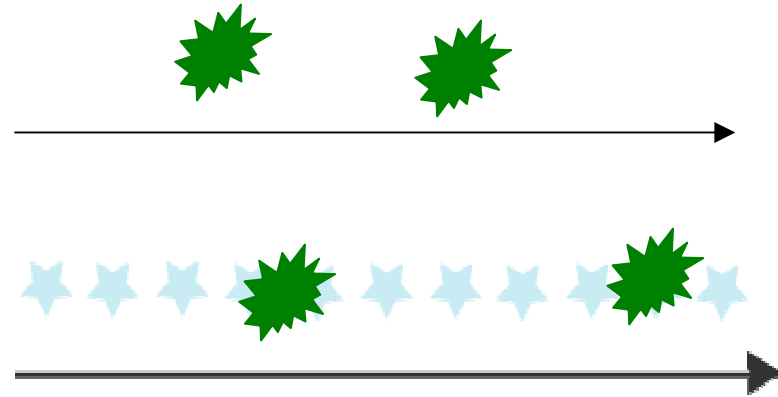
- Gain 1×10^6
- Trigger: alpha self trigger (veto by LED driver pulse)
- Procedure

Pedestal Run & Gain calibration using LED

Alpha Run @ LED OFF 20 min

Alpha Run @ LED ON 20 min

-Change LED Pulse height, rate



PMT gain calibration 1

How to gain calibration?

PMTに入射した光子が光電面で光電子をたたき出す過程をPoisson分布であるとすると

$$\sigma_{Npe} = \sqrt{Npe} \quad (Npe: \text{光電子数})$$

増幅率GのPMTと1ch当りの電荷量CのADCで見ると

$$G = \frac{C \times M}{e \times Npe} \quad (e: \text{電気素量}, M: \text{ADCスペクトルの平均値})$$

$$\therefore Npe = \frac{C \times M}{e \times G}$$

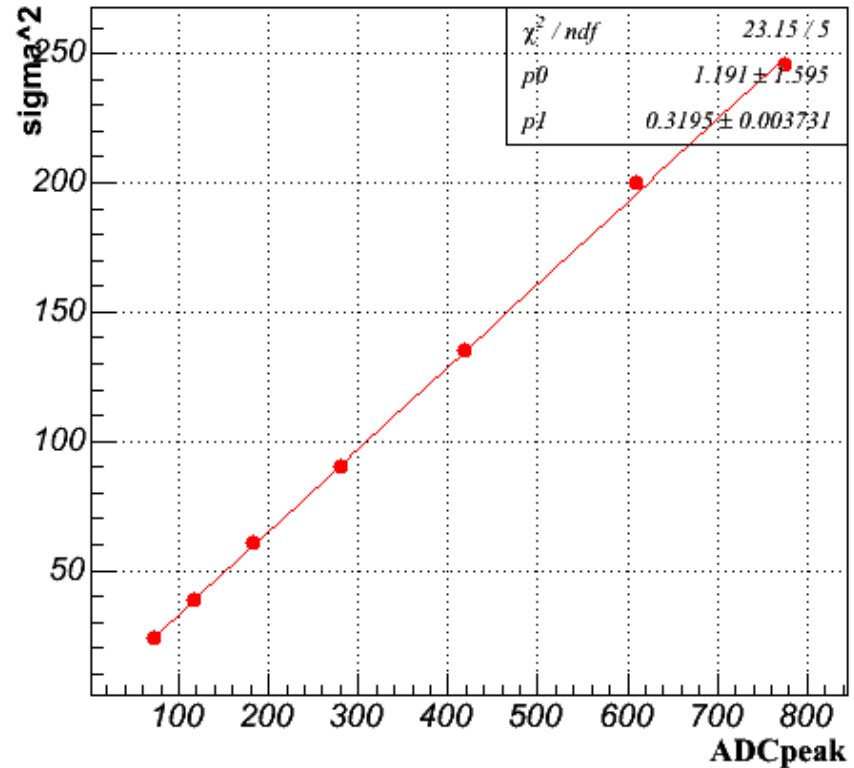
また、

$$\sigma_{Npe} = \frac{C \times \sigma_{ADC}}{e \times G}$$

以上より

$$\sigma_{ADC}^2 = \frac{C \times M}{e \times G} = \left(\frac{C \times \sigma_{ADC}}{e \times G} \right)^2$$

$$\therefore \sigma_{ADC}^2 = \frac{e \times G}{C} \times M$$



gain calibration(sample)

M v.s sigma²のplotの傾きからgainを算出